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Optical and thermoelectric properties of new Janus ZnMN₂ (M = Ge, Sn, Si and N = S, Se, Te) monolayers: a first-principles study

Basit Ali,^a Muhammad Idrees,^b Tahani A. Alrebdi,^b Bin Amin^a and Qaisar Alam^{*a}

Thermoelectric materials have received great interest because they directly tap into the vast reserves of currently underused thermal energy, in an environmentally friendly manner. In this work, we investigated the electronic, optical and thermoelectric properties of novel ZnMN₂ (M = Ge, Sn, Si and N = S, Se, Te) monolayers by performing density functional theory calculations. The dynamic and thermal stabilities of ZnMN₂ (M = Ge, Sn, Si and N = S, Se, Te) monolayers were confirmed by their phonon band structures and *ab initio* molecular dynamics (AIMD) simulations, which showed that all the studied monolayers are stable. Calculated electronic band structures showed that ZnSiTe₂, ZnGeSe₂, and ZnSnTe₂ have a direct band gap, while the remaining monolayers have an indirect band gap. Optical properties in terms of the imaginary part of the dielectric function have also been investigated, which showed that all the first excitonic peaks lie in the visible region. Transport coefficients, such as the Seebeck coefficient (*S*), electrical conductivity (σ) and power factor (PF) were calculated using the Boltzmann theory and plotted against chemical potential. The results demonstrated that the peak values of the p-type region for the PF are greater than those of the n-type region. Notably, ZnSiTe₂ exhibits a large PF due to its smaller Seebeck coefficient and higher electrical conductivity compared to ZnSnS₂, indicating that it is a promising candidate for thermoelectric applications. Our findings reveal that ZnMN₂ (M = Ge, Sn, Si and N = S, Se, Te) monolayers open up new possibilities for optoelectronics and thermoelectric device applications.

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1. Introduction

A shortage of energy is currently predicted to be a great challenge in the near future for our society.¹ It is expected that the world's energy demands will rise by up to 60% by 2030.¹ Currently, about 80% of the world's energy is generated by heat engines using fossil fuels as an energy source, which has a big drawback of carbon dioxide emission.¹ Due to this increasing demand for clean energy, researchers are trying to develop renewable energy sources to resolve energy issues and also to avoid environmental pollution.^{2,3} Recently, solar cells, wind-driven generators, thermoelectric devices and fuel cells have attracted tremendous attention. Among these resources, thermoelectric devices have gained much attention due to their many applications, including cooling devices, sensors and power generators.⁴⁻⁷ Thermoelectric materials have the ability to directly convert thermal energy, such as solar and waste energy, to electrical energy, which makes them suitable for development into sustainable energy devices.⁸⁻¹⁰ In comparison

with other energy sources, thermoelectric devices have advantages of stability, silent operation and long service life.¹¹⁻¹³ The efficiency of thermoelectric materials depends on the Seebeck coefficient (*S*), electrical conductivity (σ), total conductivity (*K*) and absolute temperature (*T*). For efficient thermoelectric materials, the electrical conductivity (σ) and Seebeck coefficient (*S*) is high and the thermal conductivity is low.^{14,15}

Since the discovery of single-layer graphene in 2004,¹⁶ research interest in the field of 2D materials has grown

Table 1 Calculated lattice constant (*A*), bond length (*d*) and band gap (*E_g*) values of ZnMN₂ (M = Si, Ge and Sn and N = S, Se and Te) monolayers

ZnMN ₂	<i>A</i> (Å)	<i>d</i> _{z-x} (Å)	<i>d</i> _{zn-y} (Å)	<i>d</i> _{x-y} (Å)	<i>E_g</i> PBE (eV)	<i>E_g</i> HSE (eV)
ZnSiS ₂	3.710	2.465	2.243	2.414	0.276	0.73
ZnSiSe ₂	3.890	2.466	2.380	2.552	0.294	0.60
ZnSiTe ₂	4.190	2.410	2.578	2.745	0.195	0.35
ZnGeS ₂	3.790	2.661	2.235	2.494	1.950	1.90
ZnGeSe ₂	3.960	2.633	2.365	2.635	0.950	1.39
ZnGeTe ₂	4.250	2.547	2.561	2.820	0.750	1.03
ZnSnS ₂	3.870	2.979	2.253	2.633	1.590	2.43
ZnSnSe ₂	4.050	2.838	2.385	2.801	1.320	2.04
ZnSnTe ₂	4.330	2.684	2.531	2.899	0.476	1.63

^aDepartment of Physics, Abbottabad University of Science and Technology, Abbottabad, Pakistan. E-mail: qaisaralam96@gmail.com; Tel: +92-346-833-4932

^bDepartment of Physics, College of Science, Princess Nourah Bint Abdulrahman University, P.O. Box 84428, Riyadh 11671, Saudi Arabia



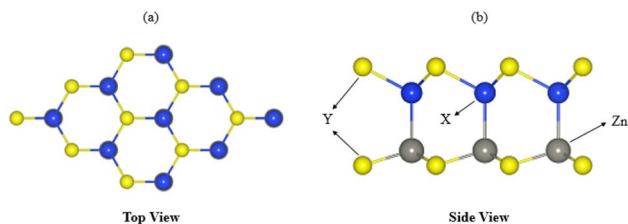


Fig. 1 Top (a) and side (b) views of ZnMN_2 ($M = \text{Si, Ge and Sn}$ and $N = \text{S, Se and Te}$) monolayers.

explosively in just a few years. Recently, thanks to developments in synthesis techniques and theoretical simulation, a variety of 2D materials have been theoretically predicted and successfully fabricated, such as hexagonal boron nitride (h-BN),¹⁷ transition-metal dichalcogenides (TMDCs),¹⁸ group-III metal chalcogenides,²⁰ group-IV and -VI metal monochalcogenides, such as SiO , SiS , GeS and SnS ,²¹ and carbide and nitride semiconductors.²² Lately, a novel class of 2D materials named Janus transition-metal dichalcogenides (JTMDCs) has attracted attention from researchers due to the distinct properties that the materials obtain from their parent transition-metal dichalcogenide monolayers. Lu and co-workers²³ confirmed the successful fabrication of JTMDCs by using chemical vapor deposition (CVD). Recently, a group of novel 2D Janus group-III

monochalcogenides with the general formula ZnXY_2 ($X = \text{Si, Ge, Sn}$ and $Y = \text{S, Se, Te}$) and constructed according to their isoelectronic mutation has been investigated, and refers to group-III monochalcogenides,²⁴ which have been attracting much interest due to their higher piezoelectricity, direct bandgaps and large effective mass difference, making them good candidates for applications in optoelectronics, photocatalysis, flexible nanodevices and electromechanical systems.²⁴

Due to their appealing mechanical and electronic properties, 2D materials with layered structures have attracted tremendous attention as efficient thermoelectric materials. In previous decades, thermoelectric properties of 2D materials have been computationally investigated and the materials have also been experimentally fabricated.^{25–27} In addition, Guo *et al.*²⁸ reported that the n-type Janus ZrSSe monolayer has excellent thermoelectric performance, which was better than that of a ZrS_2 monolayer. According to Bera *et al.*, the HfSSe monolayer was dynamically stable, and gradual increases and decreases in the bandgap were observed with changes in the applied biaxial strain. They also suggested that, due to the SOC effect, the HfSSe monolayer has a higher power factor than the HfSe_2 monolayer but lower than that of the HfS_2 monolayer.²⁹ These 2D materials exhibit fascinating properties, such as a large potential, when they are used in the fabrication of high-performance thermoelectric devices.

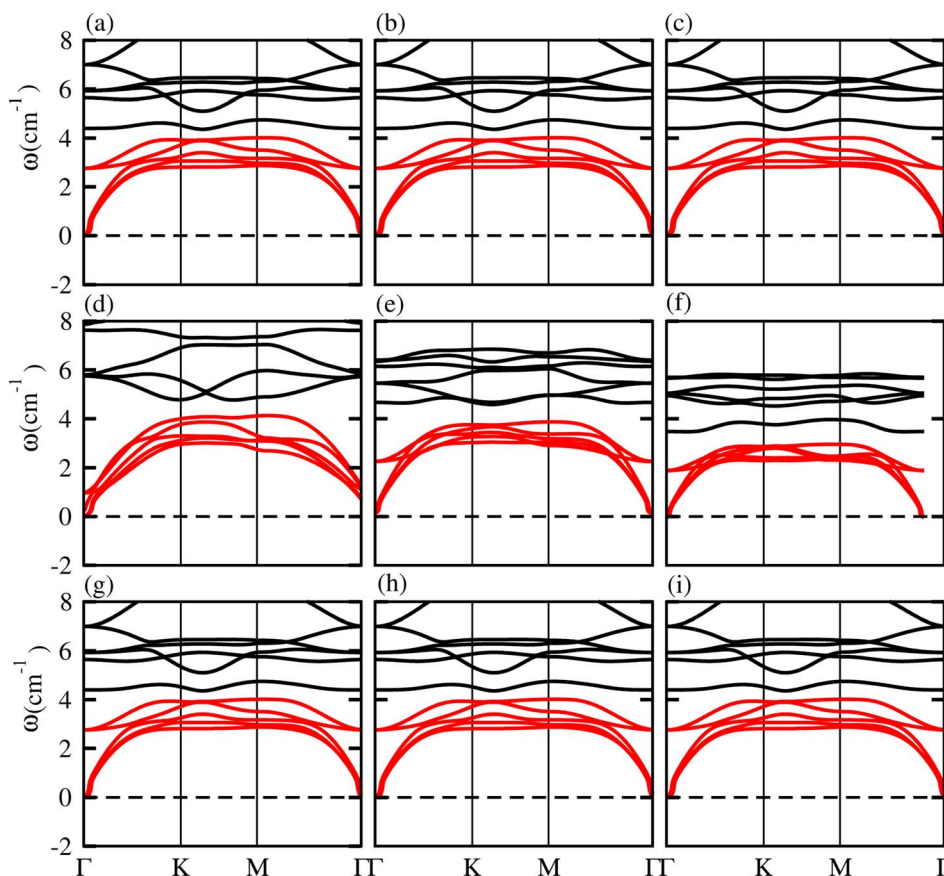


Fig. 2 Phonon band spectra of (a) ZnSiS_2 , (b) ZnSiSe_2 , (c) ZnSiTe_2 , (d) ZnGeS_2 , (e) ZnGeSe_2 , (f) ZnGeTe_2 , (g) ZnSnS_2 , (h) ZnSnSe_2 , (i) ZnSnTe_2 , monolayers.



Although interesting research results for both experimental and theoretical prediction of thermoelectric properties have been calculated, a comprehensive study of ZnMN_2 ($M = \text{Si, Ge, Sn}$ and $N = \text{S, Se, Te}$) monolayers is still missing. So, here in this paper, we investigated the structural, optoelectronic and thermoelectric properties of ZnMN_2 ($M = \text{Si, Ge, Sn}$ and $N = \text{S, Se, Te}$) monolayers using density functional theory, which is based on first-principles calculations.

II. Computational details

These calculations are based on density functional theory (DFT) techniques and approaches using PWSCF code.³⁰ In the first Brillouin zone (BZ), a Γ -point-centered $12 \times 12 \times 1$ Monkhorst-Pack k -point grid is used with a kinetic energy 450 eV. To avoid the interactions between adjacent layers of atoms, a vacuum layer with thickness of 25 Å is considered. Forces and energies are converged to 10^{-3} eV Å and 10^{-6} eV, respectively. The exchange-correlation functional is a key component that accounts for the electron–electron interactions in a system, so we used the GGA approximation.^{31,32,37} Boltzmann semiclassical theory³³ is used to calculate the electrical transport properties, like the Seebeck coefficient (S), electrical

conductivities (σ), thermal conductivities (κ) and power factor (PF), using the BoltzTraP software package. This is primarily designed for studying the thermoelectric and electronic transport properties of materials, such as electrical conductivity, the Seebeck coefficient, and the electronic density of states. BoltzTraP uses the Boltzmann transport theory and the constant relaxation time approximation.³³ The following equations can be used to express all of these parameters:

$$S = eK_B\sigma^{-1} \sum \kappa \left(-\frac{df_0}{d\varepsilon} \right) v_k^2 \tau_k \frac{(K_B - \mu)}{K_B T}, \quad (1)$$

$$\sigma = e^2 \sum \kappa \left(-\frac{df_0}{d\varepsilon} \right) v_k^2 \tau_k, \quad (2)$$

and the power factor (PF) is

$$\text{PF} = S^2 \sigma. \quad (3)$$

In the equations above, e is the charge on the elementary charge carrier, ε is the energy, K_B is the Boltzmann constant, τ_k is the relaxation time, f_0 is the Fermi distribution function, μ denotes the chemical potential, and v_k is the group velocity.

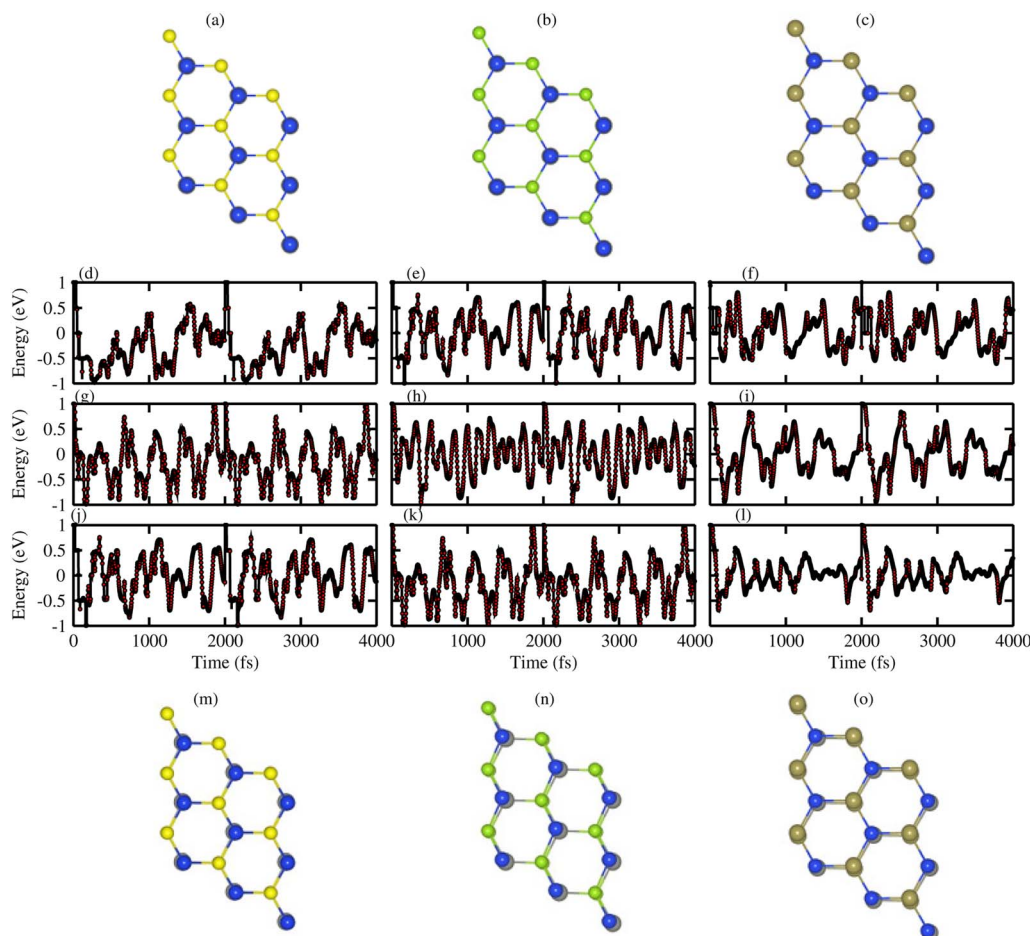


Fig. 3 AMID calculation of ZnSiN_2 ($N = \text{S, Se}$ and Te) monolayers, where (a–c) before heating; (m–o) after heating, while ((d)–(l)) is the fluctuation energy of all ZnMN_2 ($M = \text{Si, Ge}$ and Sn and $N = \text{S, Se}$ and Te) monolayers.



III. Results and discussion

Optimized lattice constants of ZnSiS₂, ZnSiSe₂, ZnSiTe₂, ZnGeS₂, ZnGeSe₂, ZnGeTe₂, ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ monolayers are listed in Table 1 and are in agreement with previously reported work.¹⁹ The geometrical structure of the ZnMN₂ monolayer consists of four sublayers with two middle layers of Zn and M (M = Si, Ge, Sn), and two outer layers of N (N = S, Se, Te). The monolayer has a hexagonal structure and is held together by covalent bonds, as presented in Fig. 1, where

the gray spheres represent the Zn atoms, the yellow spheres represent Si, Ge, or Sn, and the blue spheres represent different chalcogen atoms.^{34,35} One can easily observe that the bond lengths for the bonds containing S atoms are shorter than those containing Se and Te atoms due to the difference in electron affinities of S, Se, and Te atoms. The calculated lattice constants, bond lengths and band gaps of the various ZnMN₂ monolayers are given in Table 1.

To investigate the dynamic stability of ZnMN₂ (M = Ge, Sn, Si and N = S, Se, Te) monolayers, phonon band spectra were

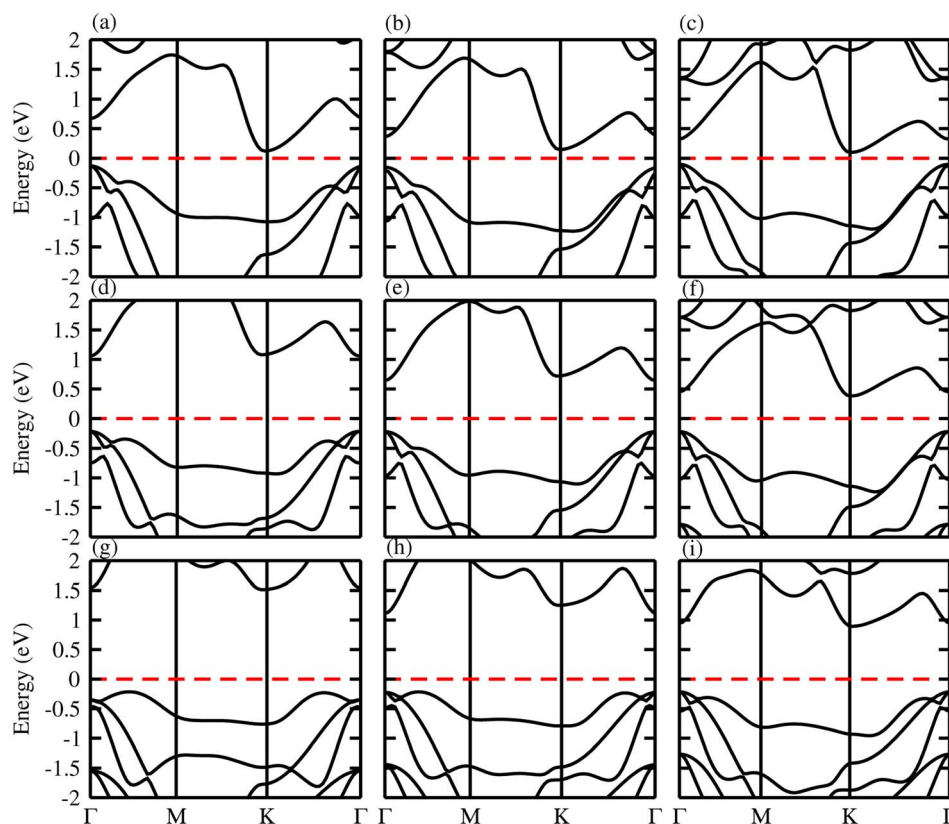


Fig. 4 Calculated band structure of (a) ZnSiS₂, (b) ZnSiSe₂, (c) ZnSiTe₂, (d) ZnGeS₂, (e) ZnGeSe₂, (f) ZnGeTe₂, (g) ZnSnS₂, (h) ZnSnSe₂ and (i) ZnSnTe₂ monolayers.

Table 2 Calculated values of the Seebeck coefficient (*S*), electrical conductivity (*σ*) and power factor (PF) at 300 K and 800 K for the p-type doped region of ZnSiS₂, ZnSiSe₂, ZnSiTe₂, ZnGeS₂, ZnGeSe₂, ZnGeTe₂, ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ monolayers.

Monolayers	300 K			800 K		
	<i>S</i> (μV/K)	<i>σ</i> (1/Ω ms)	PF (Wm K ² s)	<i>S</i> (μV/K)	<i>σ</i> (1/Ω ms)	PF (Wm K ² s)
ZnSiS ₂	450	0.89×10^{20}	0.59×10^{11}	230	0.8×10^{20}	1.2×10^{11}
ZnSiSe ₂	500	0.95×10^{20}	0.5×10^{11}	250	0.9×10^{20}	1.4×10^{11}
ZnSiTe ₂	200	0.9×10^{20}	0.55×10^{11}	120	0.86×10^{20}	1.5×10^{11}
ZnGeS ₂	500	0.90×10^{20}	1.00×10^{11}	800	0.60×10^{20}	2.00×10^{11}
ZnGeSe ₂	1800	1.00×10^{20}	0.70×10^{11}	650	0.70×10^{20}	2.50×10^{11}
ZnGeTe ₂	1200	0.80×10^{20}	0.50×10^{11}	400	0.70×10^{20}	2.20×10^{11}
ZnSnS ₂	1000	0.90×10^{20}	0.80×10^{11}	350	0.80×10^{20}	1.40×10^{11}
ZnSnSe ₂	2000	0.70×10^{20}	1.30×10^{11}	800	0.60×10^{20}	2.00×10^{11}
ZnSnTe ₂	1400	0.40×10^{20}	0.30×10^{11}	400	0.30×10^{20}	0.70×10^{11}



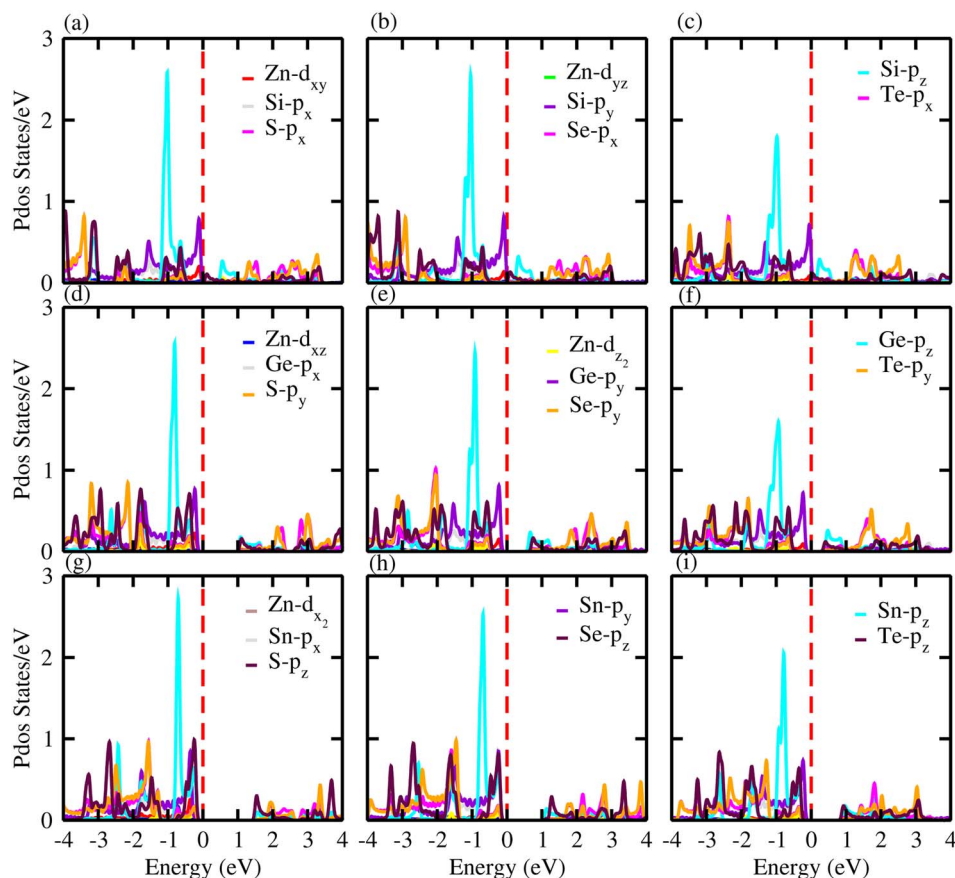


Fig. 5 Partial density of states (PDOS) for (a) ZnSiS₂, (b) ZnSiSe₂, (c) ZnSiTe₂, (d) ZnGeS₂, (e) ZnGeSe₂, (f) ZnGeTe₂, (g) ZnSnS₂, (h) ZnSnSe₂ and (i) ZnSnTe₂ monolayers in which the contributions of different atoms are labelled in the figure.

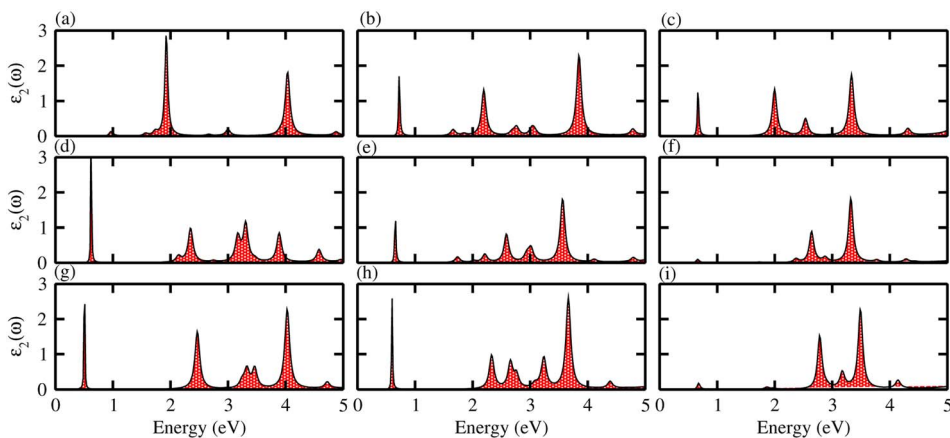


Fig. 6 Optical spectra of (a) ZnSiS₂, (b) ZnSiSe₂, (c) ZnSiTe₂, (d) ZnGeS₂, (e) ZnGeSe₂, (f) ZnGeTe₂, (g) ZnSnS₂, (h) ZnSnSe₂ and (i) ZnSnTe₂ monolayers.

calculated using the phonopy code, as shown in Fig. 2. There are four atoms in each primitive unit cell, therefore, each phonon band dispersion is composed of three acoustic zero-frequency modes and 12 optical branches. It is clear from Fig. 2 that all phonon modes have positive eigenfrequencies at the Γ -point of the Brillouin zone, indicating that ZnMN₂ (M = Ge, Sn, Si

and N = S, Se, Te) monolayers are dynamically stable, which confirms that ZnMN₂ (M = Ge, Sn, Si and N = S, Se, Te) monolayers can be experimentally synthesized in the laboratory. Furthermore, we investigated the thermal stability of these monolayers using *ab initio* molecular dynamics calculations. The results are presented in Fig. 3, confirm that there is no bond



Table 3 Calculated values of the Seebeck coefficient (S), electrical conductivity (σ) and power factor (PF) at 300 K and 800 K for the n-type doped region of ZnSiS₂, ZnSiSe₂, ZnSiTe₂, ZnGeS₂, ZnGeSe₂, ZnGeTe₂, ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ monolayers.

Monolayers	300 K			800 K		
	S ($\mu\text{V/K}$)	σ ($1/\Omega \text{ ms}$)	PF ($\text{Wm K}^2 \text{ s}$)	S ($\mu\text{V/K}$)	σ ($1/\Omega \text{ ms}$)	PF ($\text{Wm K}^2 \text{ s}$)
ZnSiS ₂	380	1.25×10^{20}	1.25×10^{11}	140	1.26×10^{20}	3.02×10^{11}
ZnSiSe ₂	400	1.30×10^{20}	1.32×10^{11}	150	1.24×10^{20}	3.80×10^{11}
ZnSiTe ₂	100	1.75×10^{20}	1.34×10^{11}	50	1.57×10^{20}	4.4×10^{11}
ZnGeS ₂	500	0.9×10^{20}	1.50×10^{11}	700	1.00×10^{20}	2.2×10^{11}
ZnGeSe ₂	1500	1.00×10^{20}	1.60×10^{11}	500	1.09×10^{20}	4.00×10^{11}
ZnGeTe ₂	1000	1.10×10^{20}	1.50×10^{11}	1000	1.09×10^{20}	4.00×10^{11}
ZnSnS ₂	500	1.00×10^{20}	1.35×10^{11}	200	0.90×10^{20}	2.20×10^{11}
ZnSnSe ₂	2200	1.80×10^{20}	1.10×10^{11}	800	0.80×10^{20}	2.00×10^{11}
ZnSnTe ₂	1000	0.09×10^{20}	1.45×10^{11}	350	0.75×10^{20}	2.50×10^{11}

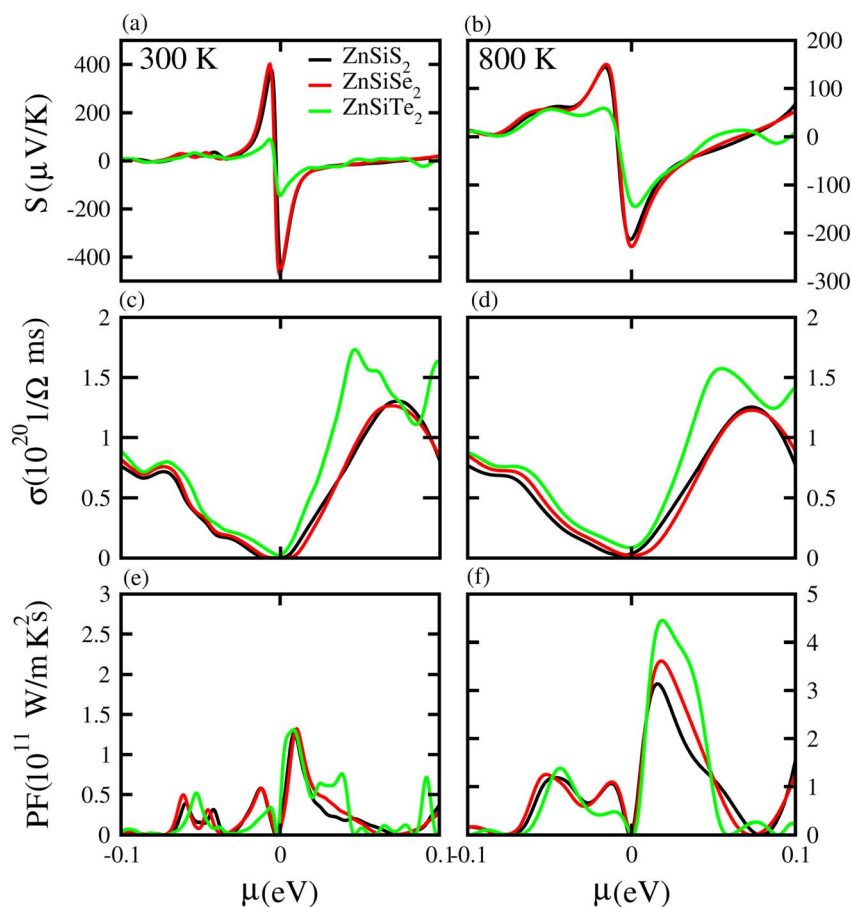


Fig. 7 Seebeck coefficient (a, b), electrical conductivity (c, d), and power factor (e, f) results for ZnSiS₂, ZnSiSe₂ and ZnSiTe₂ monolayers at 300 K and 800 K, respectively.

breaking at room temperature (300 K) to the system, hence these systems are stable at room temperature.^{36,39}

The band structure and band gap values are very sensitive to the choice of exchange correlation function, therefore, we considered both PBE and HSE06 functionals for our calculations. The calculated electronic band structures of ZnMN₂ (M = Si, Ge, Sn; N = S, Se, Te) using the PBE^{37,38} functionals are shown

in Fig. 4. One can see from the calculated electronic band structures that all the monolayers are semiconducting with a narrow band gap, and are therefore suitable for thermoelectric applications. One can also observe that ZnGeS₂, ZnGeSe₂ and ZnSnTe₂ have a direct band gap with the CBM and VBM lying at the Γ -point, while the remaining monolayers have an indirect band gap with the VBM and CBM at the Γ - and M - Γ -points,



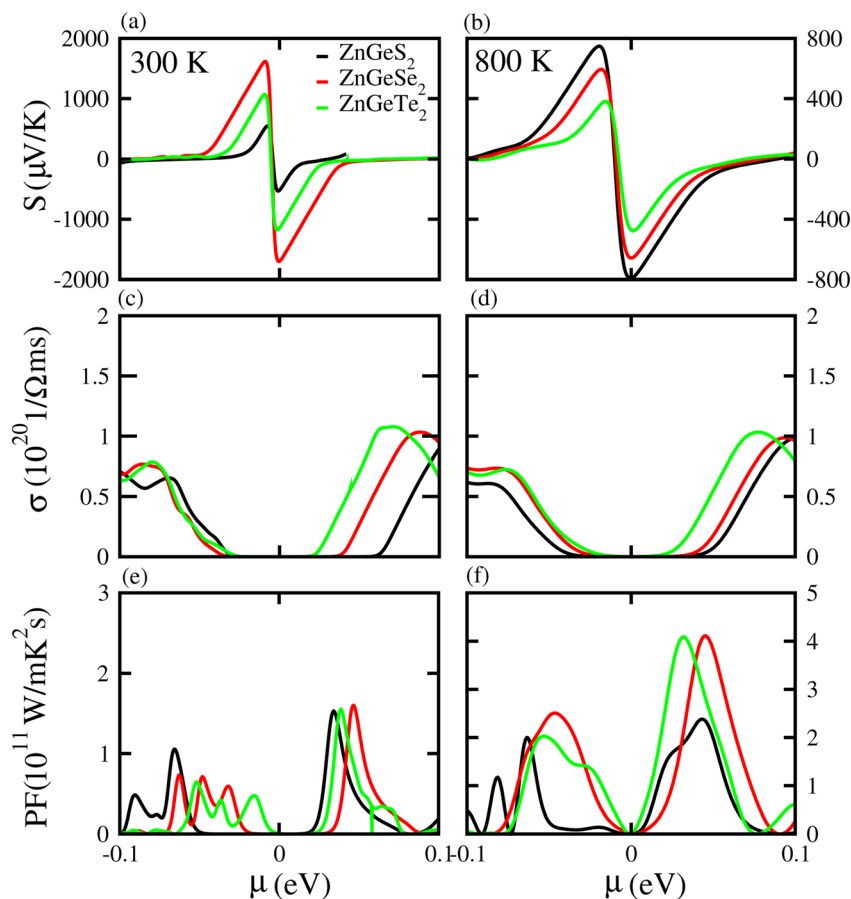


Fig. 8 Seebeck coefficient (a, b), electrical conductivity (c, d), and power factor (e, f) results for ZnGeS₂, ZnGeSe₂ and ZnGeTe₂ monolayers at 300 K and 800 K, respectively.

respectively, of the first BZ. It is also observed that due to the chalcogen atom bonded to Zn and Si, the band gap values drop from S to Te. The calculated values are listed in Table 2 and are in good agreement with previous available data.¹⁹

For further verification of the various atomic states of the monolayers, we computed the partial density of states (PDOS) of ZnXY₂ monolayers, which are depicted in Fig. 5. The contributions of different states of the atoms are shown by different colors. From the PDOS of the ZnSiS₂, ZnSiSe₂ and ZnSiTe₂ monolayers, it can be clearly seen that in the VBM the major contribution is due to the Te-p_z atom, whereas the CBM is generated by the S, Se and Te-p_z atoms. In the second row which shows results for the ZnGeS₂, ZnGeSe₂ and ZnGeTe₂ monolayers, the VBM and CBM are due to the Ge and chalcogen p_z atoms, respectively. While in the third row, which shows results for ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ monolayers, the VBM and CBM are from the Sn-p_z and chalcogen p_z states. In all these monolayers, some little contributions are also present due to Zn atoms. High mobility may be favored by this type of partially ionic nature with cross-gap hybridization.⁴⁰

The absorption spectra of systems are measured to investigate the optical properties of materials. They allow the dielectric function $\epsilon_2(\omega)$ ⁴⁶ to be determined, therefore absorption spectra are a fundamental tool for understanding the interaction of

electromagnetic radiation with matter. The imaginary part of the dielectric function $\epsilon_2(\omega)$ was calculated for the different monolayers and the results are shown in Fig. 6. Exciton peaks can clearly be seen for ZnSiS₂ (0.96 eV), ZnSiSe₂ (0.72 eV), ZnSiTe₂ (0.662 eV), ZnGeS₂ (0.61 eV), ZnGeSe₂ (0.661 eV), ZnGeTe₂ (0.64 eV), ZnSnS₂ (0.52 eV), ZnSnSe₂ (0.63 eV) and ZnSnTe₂ (0.67 eV). These values indicate strong modifications in the positions of excitons from the S atom to the Te atom, suggesting that this is promising for controlling the exciton-phonon interactions or coupling at the nanoscale, and for applications in thermal imaging sensors in the future.⁴⁷

Based on the Boltzmann theory,⁴¹ we calculated transport coefficients such as the Seebeck coefficient, electrical conductivity, and power factor against chemical potential. The Seebeck coefficient is a quantified measurement of conviced voltage,⁴² and the Seebeck coefficient of a material represents the magnitude of the thermoelectric voltage induced by a temperature difference across the material.⁴⁵ The Seebeck coefficient at (a) 300 K and (b) 800 K for ZnSiS₂ (black), ZnSiSe₂ (red) and ZnSiTe₂ (green) is presented in Fig. 7 plotted against the chemical potential, and the Seebeck coefficient values for the n-type doped region are given in Table 2 and those for the p-type doped region are given in Table 3. The Seebeck coefficient results for ZnGeS₂, ZnGeSe₂ and ZnGeTe₂ are shown in Fig. 8,



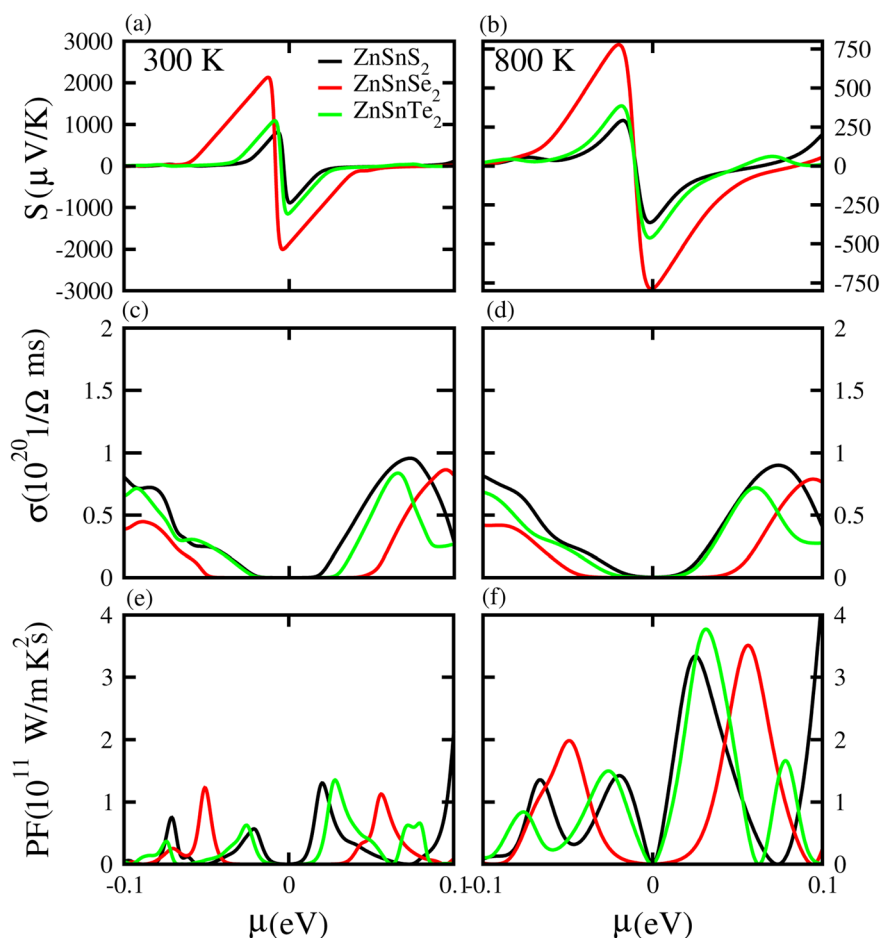


Fig. 9 Seebeck coefficient (a, b), electrical conductivity (c, d), and power factor (e, f) results for ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ monolayers at 300 K and 800 K, respectively.

and the values for the n-type doped region are given in Table 2 and those for the p-type doped region are given in Table 3. The Seebeck coefficient results for ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ are shown in Fig. 9, and the values for the n-type doped region are given in Table 2 and those for the p-type doped region are given in Table 3. From our calculations, it is clear that ZnSnSe₂ has a greater value in both the n-type and p-type regions at 300 K and 800 K. According to the preceding discussion, ZnXY₂ monolayers are p-type materials, and raising the temperature reduces the Seebeck coefficient, which makes these materials ideal for thermoelectric device applications, and similar results are also reported in ref. 43 and 44. The electrical conductivity (σ) of the materials is due to the holes and electrons in the semiconductors, and values of the electrical conductivity were calculated and plotted against μ for the ZnMN₂ (M = Si, Sn and Ge and N = S, Se and Te) monolayers. For good thermoelectric materials, we need high σ values. The calculated values for σ for both n-type and p-type doped regions are given in Tables 2 and 3, respectively, for 300 K and 800 K. Our results show that ZnSiTe₂ had a larger value in both the n-type and p-type regions at 300 K and 800 K. According to the preceding discussions, ZnMN₂ monolayers are p-type materials, and raising the temperature reduces the Seebeck coefficient. To measure the

thermoelectric power of a material, the power factor (PF) is one of the best parameters to describe the efficiency of that material with the general formula $PF = \sigma S^2$, where S represents the Seebeck coefficient and σ is the electrical conductivity of the material. The calculated values of the power factor at 300 K and 800 K are shown in Fig. 7 for monolayers of ZnSiS₂, ZnSiSe₂, and ZnSiTe₂, Fig. 8 for monolayers of ZnGeS₂, ZnGeSe₂, and ZnGeTe₂, and Fig. 9 for monolayers of ZnSnS₂, ZnSnSe₂ and ZnSnTe₂. The values are given in Tables 2 and 3. It is obvious from Fig. 7(e, f), 8(e, f) and 9(e, f) that the peak values of the PF at both 300 K and 800 K in the p-type region are greater than in the n-type region. Furthermore, it can be seen that ZnSnS₂ has a large PF at 300 K and 800 K because of its smaller Seebeck coefficient and higher electrical conductivity than ZnSiTe₂, making it a promising candidate for thermoelectric applications.⁴⁸

IV. Conclusions

Using DFT, the structural, electronic, optical and thermoelectric properties of novel 2D Janus ZnMN₂ (M = Si, Ge, Sn and N = S, Se, and Te) monolayers constructed according to their isoelectronic mutation have been investigated. Moreover, a direct band



gap was observed in ZnSiS₂, ZnSiSe₂ and ZnSiTe₂ monolayers, while ZnGe₂, ZnGeSe₂, ZnGeTe₂, ZnSnS₂, ZnSnSe₂ and ZnSnTe₂ possessed an indirect band gap. The electronic band structures revealed the semiconducting nature of the monolayers. Furthermore, values for the imaginary part of the dielectric function were calculated, which indicated strong modifications in the positions of excitons from the S atom to the Te atom, suggesting that this is promising for controlling the exciton-phonon interactions. Finally, we investigated the thermoelectric properties, including the Seebeck coefficient (*S*), electrical conductivity (σ), and power factor (PF), at temperatures of 300 K and 800 K, based on Boltzmann theory. The results confirmed that the peak values of the PF at 300 K and 800 K in the n-type region are greater than in the p-type region. Furthermore, it can be seen that ZnSiTe₂ has a large PF at 300 K and 800 K because of its smaller Seebeck coefficient and higher electrical conductivity than ZnSnS₂, making it a promising candidate for thermoelectric applications.

Conflicts of interest

There are no conflicts to declare.

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